

Search Notes

Application/Control No.

10/644,961

Examiner

James O. Hansen

Applicant(s)/Patent und r
Re xamination

LEE ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
<i>searched Updated 6/2/06 Jph</i>			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR